VORTEX-PENETRATION FIELD AT A GROOVE WITH A DEPTH SMALLER THAN THE PENETRATION DEPTH*

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Abstract

Analytical formula to evaluate the vortex-penetration field at a groove with a depth smaller than penetration depth is derived, which can be applied to surfaces of cavities or test pieces made from extreme type II superconductors such as nitrogen-doped Nb or alternative materials like Nb₃Sn or NbN.

INTRODUCTION

The vortex-penetration field B_v is the field at which a vortex overcome the Bean-Livingston barrier [1] and start to penetrate into the superconductor (SC). B_v of extreme type II SC, where the penetration depth λ is much larger than the coherence length ξ , can be evaluated in the framework of the London theory. Materials that attract much attentions in the field of SC accelerating cavity such as dirty Nb like nitrogen-doped Nb and alternative materials like Nb₃Sn or NbN are all categorized into this class. For an SC with an ideal flat surface, B_v is given by $B_v = \phi_0/(4\pi\lambda\xi) \simeq 0.7B_c$, where ϕ_0 is the flux quantum and B_c is the thermodynamic critical magnetic field. Actually, experiments shows fields can not reach such a level. More realistic assumption, such as surface irregularities, should be incorporated.

In this paper we consider a groove with a depth δ smaller than λ as a simple example of a surface irregularity, which assume irregularities on cavity surfaces or test pieces made from extreme type II SC such as a nitrogen-doped Nb or alternative materials. B_{ν} at this type of irregularity has not been obtained so far, in spite of the fact that there are many studies on B_{ν} at a surface irregularity [2, 3, 4, 5].

MODEL

Let us consider a groove shown in Fig. 1(a). Gray and white regions represent the SC and the vacuum, respectively. Surface, groove and applied magnetic-field are perpendicular to the *x*-*y* plane. The half width of the groove and the slope angle are given by R and $\pi(\alpha - 1)/2$, respectively, and thus the depth is given by $\delta = R \tan[\pi(\alpha - 1)/2]$, where $1 < \alpha < 2$. The depth is assumed to satisfy $\xi \ll \delta \ll \lambda$.

FORCES ACTING ON A VORTEX AND THE VORTEX-PENETRATION FIELD

Suppose a vortex is at the position $(x, y) = (0, \delta + \xi)$, inside the bottom of groove. This vortex feels two distinct

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Figure 1: (a) Groove with a depth that is smaller than the penetration depth of the material and (b) its map on the *w*-plane.

forces: (i) \mathbf{F}_{M} a force from a Meissner current due to an external field and (ii) \mathbf{F}_{I} a force due to an image antivortex that is introduced to satisfy the boundary condition of zero current normal to the surface. The former and the latter draw the vortex to the inside and the outside of the SC, respectively. The vortex-penetration field is a field at which these competing forces are balanced.¹

Force Due to an External Field

An external magnetic-field pushes a vortex into the superconductor by a force $\mathbf{F}_{M} = \mathbf{J}_{M} \times \phi_{0} \hat{\mathbf{z}}$, where \mathbf{J}_{M} is a Meissner screening-current, $\phi_0 = 2.07 \times 10^{-15}$ Wb is the flux quantum and $\hat{\mathbf{z}}$ is the unit vector parallel to the *z*-axis. To evaluate \mathbf{F}_{M} , we evaluate \mathbf{J}_{M} as follows. \mathbf{J}_{M} satisfies div $\mathbf{J}_{M} = 0$ and one of the Maxwell equations, \mathbf{J}_{M} = rot **H**, where the magnetic field **H** plays the role of the vector potential of J_{M} . For our two-dimensional problem, **H** can be written as $\mathbf{H} = (0, 0, -\psi(x, y))$, and $\mathbf{J}_{\mathbf{M}}$ is given by $\mathbf{J}_{\mathrm{M}} = \operatorname{rot} \mathbf{H} = (-\partial \psi / \partial y, \partial \psi / \partial x, 0)$. On the other hand, since λ is assumed to be much larger than the typical scale of the model, the London equation is reduced to rot $\mathbf{J}_{\mathrm{M}} = -\Delta \mathbf{H} = \mathbf{0}$, which allows us to introduce a scalar potential of J_M . For our two-dimensional problem the scalar potential can be written as $\phi(x, y)$, and **J**_M is given by $\mathbf{J}_{\mathrm{M}} = -\operatorname{grad} \phi = (-\partial \phi / \partial x, -\partial \phi / \partial y, 0)$. Since

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¹ Detailed reviews are given in Ref. [6, 7].

both the two approaches should lead the same J_M , we find

$$J_{\mathrm{M}x} = -\frac{\partial \phi}{\partial x} = -\frac{\partial \psi}{\partial y}, \qquad \qquad J_{\mathrm{M}y} = -\frac{\partial \phi}{\partial y} = \frac{\partial \psi}{\partial x}, \qquad (1)$$

which are the Cauchy-Riemann conditions. Thus a function defined by

$$\Phi_{\rm M}(z) \equiv \phi(x, y) + i\psi(x, y), \qquad (2)$$

is an holomorphic function of a complex variable z = x + iy, which is called the complex potential. If $\Phi_{\rm M}(z)$ is given, components of J_M are derived from

$$J_{\mathrm{M}x} - iJ_{\mathrm{M}y} = -\frac{\partial\phi}{\partial x} + i\frac{\partial\phi}{\partial y} = -\frac{\partial\phi}{\partial x} - i\frac{\partial\psi}{\partial x} = -\frac{d\Phi_{\mathrm{M}}(z)}{dz}, \quad (3)$$

where the property of the holomorphic function, $\Phi'_{M}(z) =$ $\partial \phi / \partial x + i \partial \psi / \partial x$, is used. Thus our two-dimensional problem is reduced to a problem of finding $\Phi_{\rm M}(z)$.

The complex potential $\Phi_{\rm M}(z)$ is derived from a complex potential $\Phi_{M}(w)$ on a complex *w*-plane shown in Fig. 1(b) through a conformal mapping z = F(w), by which orthogonal sets of field lines in the w-plane are transformed into those in the z-plane. The map is given by the Schwarz-Christoffel transformation.

$$z = F(w) = K_1 \int_0^w f(w) dw + K_2.$$
 (4)

The function f(w) is given by

$$f(w) = w^{\alpha - 1} (w^2 - 1)^{-\frac{\alpha - 1}{2}},$$
(5)

and the constants K_1 and K_2 are given by

$$K_1 = \frac{\sqrt{\pi R}}{\Gamma(\frac{\alpha}{2})\Gamma(\frac{3-\alpha}{2})\cos\frac{\pi(\alpha-1)}{2}},$$
 (6)

$$K_2 = i\delta = iR \tan \frac{\pi(\alpha - 1)}{2}, \qquad (7)$$

which are determined by conditions that A' and C' on the w-plane are mapped into A and C on the z-plane, respectively. The complex potential on the w-plane is given by $\Phi_{\rm M}(w) = J_0 w \ (J_0 \equiv K_1 J_0)$, which reproduces the current distribution on the w-plane: $-\Phi'_{M}(w) = -\tilde{J}_{0}$. Thus the complex potential on the z-plane is given by

$$\Phi_{\mathrm{M}}(z) = \widetilde{\Phi}_{\mathrm{M}}(F^{-1}(z)) = F^{-1}(z)\widetilde{J}_{0}, \qquad (8)$$

where F^{-1} is an inverse function of F.

All that is left is to substitute Eq. (8) into Eq. (3). The we obtain

$$J_{Mx} - iJ_{My} = -\frac{J_0}{f(w)},$$
 (9)

where $dF^{-1}/dz = dw/dz = (dz/dw)^{-1} = (dF/dw)^{-1}$ is used. In order to evaluate J_M at the vortex position z = $z_v \equiv i(\delta + \xi)$, w corresponding to z_v is necessary. While no closed form of $w = F^{-1}(z)$ exist, that of an approximate

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expression can be derived. Suppose $w = i\epsilon \ (0 < \epsilon \ll 1)$ is mapped into $z = z_v$ on the z-plane by Eq. (4). Then we obtain $i(\delta + \xi) \simeq i\delta + iK_1\epsilon^{\alpha}/\alpha$, and find a relation

$$\epsilon = \left(\frac{\alpha\xi}{K_1}\right)^{\frac{1}{\alpha}},\tag{10}$$

which immediately leads

$$f(i\epsilon) \simeq \epsilon^{\alpha-1} = \left(\frac{\alpha\xi}{K_1}\right)^{\frac{\alpha-1}{\alpha}}.$$
 (11)

Substituing Eq. (11) into Eq. (9), we find

$$J_{Mx}(z_{\nu}) = -\left(\frac{K_1}{\alpha\xi}\right)^{\frac{\alpha-1}{\alpha}} J_0, \qquad J_{My}(z_{\nu}) = 0.$$
(12)

Then the force due to the external field can be evaluated as

$$\mathbf{F}_{\mathrm{M}} = \mathbf{J}_{\mathrm{M}} \times \phi_{0} \hat{\mathbf{z}}$$
$$= \left(\frac{\sqrt{\pi}}{\Gamma(\frac{\alpha}{2})\Gamma(\frac{3-\alpha}{2})\alpha \cos \frac{\pi(\alpha-1)}{2}} \frac{R}{\xi} \right)^{\frac{\alpha-1}{\alpha}} \phi_{0} J_{0} \hat{\mathbf{y}}, (13)$$

where $\hat{\mathbf{y}}$ is the unit vector parallel to the y-axis.

Force Due to the Image Antivortex

A current associated with a vortex near the surface satisfies the boundary condition of zero current normal to the surface. This boundary condition can be satisified by removing the surface and introducing appropriate image antivortex (antivotices). Then the current can be expressed as $\mathbf{J}_{V+I} = \mathbf{J}_V + \mathbf{J}_I$, where \mathbf{J}_V and \mathbf{J}_I represent currents due to the vortex and image antivortex (antivortices), respectively. The force due to the image antivortex (antivortices) \mathbf{F}_{I} is given by $\mathbf{F}_{I} = \mathbf{J}_{I} \times \phi_{0} \hat{z}$. Thus our next task is to evaluate \mathbf{J}_{I} at the vortex position $z = z_v \equiv i(\delta + \xi)$.

A scalar and a vector potentials of \mathbf{J}_{V+I} , and the complex potential Φ_{V+I} can be introduced in much the same way as the above. Then components of \mathbf{J}_{V+I} are given by

$$J_{\mathrm{V+I}x} - iJ_{\mathrm{V+I}y} = -\frac{d\Phi_{\mathrm{V+I}}(z)}{dz},\qquad(14)$$

where $\Phi_{V+I}(z)$ can be derived from the complex potential $\Phi_{V+I}(w)$ on the w-plane. Since the vortex and the image antivortex on the *w*-plane are located at $w = +i\epsilon$ and $-i\epsilon$, respectively, $\Phi_{V+I}(w)$ is given by

$$\widetilde{\Phi}_{V+I}(w) = \frac{i\phi_0}{2\pi\mu_0\lambda^2} \left[\log(w - i\epsilon) - \log(w + i\epsilon)\right], \quad (15)$$

and thus the complex potential on the z-plane is given by

$$\Phi_{V+I}(z) = \widetilde{\Phi}_{V+I}(F^{-1}(z)).$$
(16)

F is the Schwarz-Christoffel transformation given by Eq. (4). Substituting Eq. (16) into Eq. (14), we find

$$J_{V+Ix} - iJ_{V+Iy} = -\frac{d\Phi_{V+I}(z)}{dz}, \qquad (14)$$
where $\Phi_{V+I}(z)$ can be derived from the complex potential
 $\widetilde{\Phi}_{V+I}(w)$ on the *w*-plane. Since the vortex and the image
antivortex on the *w*-plane are located at $w = +i\epsilon$ and $-i\epsilon$,
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F is the Schwarz-Christoffel transformation given by
Eq. (4). Substituting Eq. (16) into Eq. (14), we find
 $J_{V+Ix} - iJ_{V+Iy} = \frac{1}{K_1 f(w)} \frac{-i\phi_0}{2\pi\mu_0\lambda^2} \left(\frac{1}{w - i\epsilon} - \frac{1}{w + i\epsilon}\right). \qquad (17)$
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At the vortex position $z = z_v$ or $w = i\epsilon$, the first term of the square bracket diverges, which is contribution from the current due to the vortex and should be abandoned for the computation of **J**_I. Then **J**_I at the vortex position is give by

$$J_{\mathrm{I}x} - iJ_{\mathrm{I}y} = \frac{1}{K_1 f(i\epsilon)} \frac{i\phi_0}{2\pi\mu_0 \lambda^2} \left(\frac{1}{2i\epsilon}\right) = \frac{\phi_0}{4\pi\mu_0 \lambda^2 \xi\alpha}, \quad (18)$$

or,

$$J_{Ix}(z_{\nu}) = \frac{\phi_0}{4\pi\mu_0\lambda^2\xi\alpha}, \qquad J_{Iy}(z_{\nu}) = 0, \qquad (19)$$

where a relation $\epsilon f(i\epsilon) = \epsilon^{\alpha} = \alpha \xi/K_1$ is used. Then the force due to the image anti-vortex is given by

$$\mathbf{F}_{\mathrm{I}} = \mathbf{J}_{\mathrm{M}} \times \phi_0 \hat{\mathbf{z}} = -\frac{\phi_0^2}{4\pi\mu_0 \lambda^2 \xi \alpha} \hat{\mathbf{y}} \,. \tag{20}$$

Note that Eq. (20) is reduced to the force from the flat surface when $\alpha = 1$, and is maximized when the groove is a crack with $\alpha \simeq 2$. Eq. (20) is identical with that given in Ref. [3].

Vortex-penetration field

The vortex-penetration field B_v can be evaluated by balancing the two competing forces given by Eq. (13) and (20):

$$\left(\frac{\sqrt{\pi}}{\Gamma(\frac{\alpha}{2})\Gamma(\frac{3-\alpha}{2})\alpha\cos\frac{\pi(\alpha-1)}{2}}\frac{R}{\xi}\right)^{\frac{\alpha-1}{\alpha}}\phi_0 J_0 = \frac{\phi_0^2}{4\pi\mu_0\lambda^2\xi\alpha}.$$
 (21)

The surface current J_0 is given by $J_0 = -\mu_0^{-1} dB/dx|_{x=0} = B_0/\mu_0 \Lambda$, where B_0 is the surface magnetic-field and Λ is a quantity with the dimension of length. For examples,

$$\Lambda = \begin{cases} \lambda & (\text{semi-infinite SC}), \\ \lambda \frac{\cosh \frac{d_{\mathcal{S}}}{\lambda} + (\frac{\lambda'}{\lambda} + \frac{d_{\mathcal{I}}}{\lambda}) \sinh \frac{d_{\mathcal{S}}}{\lambda}}{\sinh \frac{d_{\mathcal{S}}}{\lambda} + (\frac{\lambda'}{\lambda} + \frac{d_{\mathcal{I}}}{\lambda}) \cosh \frac{d_{\mathcal{S}}}{\lambda}} & (\text{multilayer SC}). \end{cases}$$
(22)

where d_S , d_I , and λ' are an SC layer thickness, insulator layer thickness and penetration depth of SC substrate material, respectively.² The finally we obtain

$$B_{\nu} = \frac{\phi_0}{4\pi\lambda\xi} \frac{\Lambda}{\lambda} \frac{1}{\alpha} \left(\frac{\Gamma(\frac{\alpha}{2})\Gamma(\frac{3-\alpha}{2})\alpha\cos\frac{\pi(\alpha-1)}{2}}{\sqrt{\pi}} \frac{\xi}{R} \right)^{\frac{\alpha-1}{\alpha}}, \quad (23)$$

Note that Eq. (23) is reduced to Bv of semi-infinite SC or multilayer SC with ideal flat-surface when $\alpha = 1$.

SUMMARY

Analytical formula to evaluate the vortex-penetration field at a groove with a depth smaller than penetration depth was derived. The formula would be useful to analyze relation between surfaces and performance-test results of cavities or test pieces made from extreme type II SC such as a dirty Nb like nitrogen-doped Nb or alternative materials like Nb₃Sn or NbN.

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² See Ref. [8, 9]. Detailed reviews are given in Ref. [6, 7, 10].